

<b>Notice of References Cited</b>	Application/Control No. 10/789,393		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner EDNY LABBEES		Art Unit 2612	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0025823	02-2002	Hara, Kentaro	455/456
*	B	US-7,046,119 B2	05-2006	Ghabra et al.	340/5.72
*	C	US-2003/0006879	01-2003	Kang et al.	340/5.61
*	D	US-6,778,065	08-2004	Asakura et al.	340/5.61
*	E	US-6,556,125	04-2003	Rohrl, Thomas	340/5.62
*	F	US-5,293,160	03-1994	Kurozu et al.	340/5.3
*	G	US-5,157,389	10-1992	Kurozu et al.	340/5.3
*	H	US-6,906,612	06-2005	Ghabra et al.	340/5.61
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.